

**Search Notes**

Application/Control No.

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Examiner

Vivian Chen

Applicant(s)/Patent under  
Reexamination

HAYAKAWA ET AL.

Art Unit

1773

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

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interference search history		6/11/2006	VC

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
inventor search	6/5/2006	VC
EAST text search history	6/11/2006	VC